

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/799,316	PITSIANIS ET AL.	
Examiner	Art Unit	
Tan V Mai	2103	

SEARCHED						
Class	Subclass	Date	Examiner			
708	492	11/21/2007	MAI			
-						

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	_				
	<u> </u>				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Inventor(s) search Double Patent Check Data Bases Search (see search history printout(s))	11/21/2007	MAI	
-			
· 			
,			